

# PCM AMI Line Receiver and Clock Recovery Circuit

# **GENERAL DESCRIPTION**

The XR-T5640 is a monolithic bipolar IC designed for T1 type line receiver application operating at 1.544 M bit/s. It provides all the active circuitry required to perform automatic line build out (ALBO), threshold detection, binary NRZ data and clock recovery.

A clock recovery using crystal filter circuit version of the XR-T5640 is also available as XR-T5740.

# **FEATURES**

On Chip NRZ Data and Clock Recovery
Less than 10 ns Sampling Pulse Over the Operating
Range
Triple Matched ALBO Ports
Single 5.1 Power Supply

# APPLICATIONS

T1 PCM Line Receiver T1C PCM Line Receiver (requires external gain) General Purpose Bipolar Line Receiver

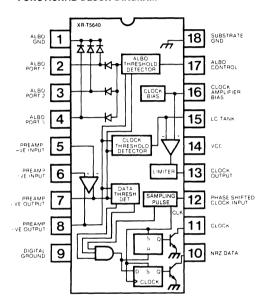
# **ABSOLUTE MAXIMUM RATINGS**

Storage Temperature	-65°C to $+150$ °C
Operating Temperature	-40°C to +85°C
Supply Voltage	-0.5  to  +10 V
Supply Voltage Surge (10 ms)	+ 25V
Input Voltage (except Pins 2,3,4,17)	– 0.5 to 7V
Input Voltage (Pins 2,3,4,17)	-0.5  to  +0.5 V
Data Output Voltage (Pins 10,11)	20V
Voltage Surge (Pins 5,6,10,11) (10 r	msec only) 50V

### ORDERING INFORMATION

Part Number	Package	Operating Temperature
XR-T5640	Ceramic	-40°C to 85°C

# **FUNCTIONAL BLOCK DIAGRAM**



## SYSTEM DESCRIPTION

The XR-T5640 is designed as a receiver for interfacing T1 PCM carrier lines on plastic or pulp insulated cables. It can also be used as a general purpose alternate mark inversion (AMI) receiver.

The XR-T5640 is a modified version of XR-T5620 PCM repeater IC. It contains all the active circuitry needed to build a T1 line receiver for interfacing up to 6300 ft. The preamplifier, the clock amplifier, threshold detectors, ALBO port, data latches and output drivers are similar to the ones on XR-T5620. Clock extraction is done by means of an L-C tank circuit.

Bipolar +1 and -1 pulses are combined within the IC to form a binary non-return to zero PCM signal at Pin 10. A synchronous clock signal is made available at Pin 11. Both outputs have open collector transistors.

ELECTRICAL CHARACTERISTICS Test Conditions:  $T_A = 25$ °C,  $V_{CC} = 5.1$  V  $\pm$  5%

PARAMETERS	MIN	TYP	MAX	UNIT	CONDITIONS
Supply Current		22	30	mA	ALBO Off
Clock & Data Output Leakage Current		0	100	μΑ	V <sub>pull-up</sub> = 15V At Unity DC Gain
Amplifier Pin Voltages	2.4	2.9	3.4	V	At Unity DC Gain
Amplifier Output Voltage Swing	2.2			٧	
Amplifier Output Offset Voltage	- 50	0	50	mV	$R_S = 8.2 \text{ k}\Omega$
Amplifier Input Bias Current	_		5	μΑ	
ALBO on Current	3			mA	
Drive Current	L	1		mA	
AC CHARACTERISTICS					·
Pre-Amplifier					
AC Gain at 1 MHz		50		dB	Open Loop
Input Impedance	20			kΩ	
Output Impedance	1		200	Ω	
Clock Amplifier				-10	0
AC Gain	10	32		dB	Open Loop
– 3 dB Bandwidth Delay	10	10	ŧ	MHz	
Output Impedance	ļ	10	200	ns Ω	
	<u></u>	L	200	11	L
ALB0					year
Off Inpedance	20			kΩ	
On Impedance			25	Ω	
CLOCK DATA OUTPUT BUFFERS				,	$R_L = 130\Omega$ , $V_{pull-up} = 5.1V \pm 5\%$
Rise Time		30		ns	
Fall Time	1	30		ns	
Output Pulse Width		244		ns	
Sample Pulse Width	1	10		ns	
VOL		0.7		٧	
L sink	i .	35		mA	
THRESHOLDS					
ALBO	1.4	1.5	1.6	٧.	
Clock Drive Current Peak		1.0		mA	At Vo = VALBO Threshold
Clock Thresholds					1
% of ALBO	63		75	%	
Data Threshold			]		
% of ALBO	40	46	52	%	